Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	,
10/707,749	FUNG ET AL.	
Examiner	Art Unit	•
Y. J. Han	2838	

SEARCHED				
Class	Subclass	Date	Examiner	
363	16			
	17			
	21.01- 21.18			
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	97			
	131	9/05	SH	
See sear	ch report	9/05		

INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
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